INFORMATION

PRODUCT No.: Q13MC1461000600

MODEL: MC-146

INFO. No.: A14-016-22A

DATE: Apr. 18. 2014

SEIKO EPSON CORPORATION

8548 Naka-minowa Minowa-machi Kamiina-gun Nagano-ken 399-4696 Japan

INTRODUCTION

- 1. The contents is subject to change without notice. Please exchange the specification sheets regarding the product's warranty.
- 2. This sheet is not intended to guarantee or provide an approval of implementation of industrial patents.
- 3. We have prepared this sheet as carefully as possible. If you find it incomplete or unsatisfactory in any respect, We would welcome your comments.

1) RoHS compliant

- MC-146 contains lead in high melting type solder which is exempted in RoHS directive.
- 2) This Product supplied (and any technical information furnished, if any) by Seiko Epson Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes.Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.
- 3) This product listed here is designed as components or parts for electronics equipment in general consumer use.

 We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an systems, and medical equipment, the functional purpose of which is to keep extra high reliability, such as satellite, rocket and other space life.

Product No. / Model

The product No. of this crystal unit is Q13MC1461000200. The model is MC-146.

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[1] Absolute maximum ratings

			R	Rating value			
No.	Item	Symbol	Min.	Тур.	Max.	Unit	Note
1	Storage temperature range	T_stg	- 55		+ 125	°C	Suppose to be within CI STD at $+ 25$ °C ± 3 °C.
2	Maximum level of drive	GL		1.0		μW	

[2] Operating range

			R	Rating value			
No.	Item	Symbol	Min.	Тур.	Max.	Unit	Note
1	Operating temperature range	T_use	- 40		+ 85	°C	
2	Level of drive	DL	0.01	0.1	0.5	μW	
3	Vibration mode		Fundamental			-	

[3] Static characteristics

No.	Item		Symbol	Value	Unit	Conditions
1	Nominal Frequency		f_nom	32.768	kHz	
2	Frequency tolerance	e	f_tol	± 20	× 10 ⁻⁶	CL = 6 pF Ta = $+25 \pm 3$ °C Level of drive : 0.1 μ W Not include aging
3	Motional resistance		R1	65 Max.	kΩ	
4	Motional capacitance		C1	1.9 Тур.	fF	CI meter : Saunders 140B Level of drive : 0.5 µW
5	Shunt capacitance		C0	0.8 Typ.	pF	,
6	Frequency	Turnover temperature	Ti	+ 25 ± 5	°C	Values are calculated by The frequencies
	temperature characteristics	Parabolic coefficient	В	- 0.04 Max.	× 10 ⁻⁶ /°C ²	at + 10, + 25, + 40 °C with C-MOS circuit.
7	Isolation resistance		${ m I\!R}$	500 Min.	МΩ	DC 100 V ± 15, 60 seconds Between terminal # 1 and terminal # 4
8	Frequency Aging		f_age	± 3	× 10 ⁻⁶ /year	Ta = $+25$ °C ± 3 °C Level of drive : 0.1 μW

[4] Environmental and Mechanical characteristics

No.	Items	Value *1*2 $\Delta f/f [1 \times 10^{-6}]$	2 Conditions
1	Shock	*3 ±5	100 g dummy (EPSON TOYOCOM Standard) drop from 1500 mm height on to the concrete 3 directions 10 times
2	Vibration	*3 ±3	10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s ² 10 Hz \rightarrow 500 Hz \rightarrow 10 Hz 15 min./cycle 6 h (2 hours, 3 directions)
3	Resistance to soldering heat (Reflow characteristics)	*3 ± 5	Treat the Reflow 2 times by the following profile in the next page
4	High temperature storage	*3 a)±20 b)±10	a) + 125 °C × 1 000 h b) + 85 °C × 1 000 h
5	Low temperature storage	*3 ± 10	- 55 °C × 1 000 h
6	Temperature humidity storage	*3 ± 10	+ 85 °C × 85 %RH × 1000 h
7	Temperature cycle	*3 ± 10	- 55 °C ↔ + 125 °C 30 minutes at each temperature 100 cycles
8	Shear	No peeling-off at a	10 N press the side for 10 s \pm 1 s. Ref. IEC 60068-2-21
9	Pull-off	No peeling-off at a	10 N press the side for 10 s \pm 1 s. Ref. IEC 60068-2-21
10	Substrate bending	No peeling-off at a	Bending width reaches 3mm and hold for 5 s \pm 1 s \times 1 time Ref. IEC 60068-2-21
11	Solderability	Termination must be sold	
12	Solvent resistance	The marking shall b	Ref. JIS C 0052 or IEC 60068-2-45

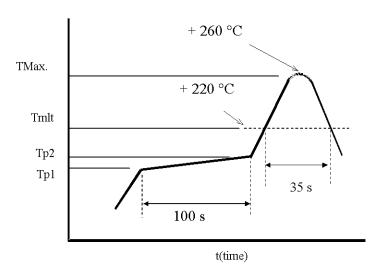
Note

- 1. *1 Each test done independently.
- 2. *2 Measuring 1 h to 24 h later leaving in room temperature after each test.
- 3. *3 Pre conditionings
 - 1. + 125 °C × 24 h to +85 °C × 85 %RH × 48 h \rightarrow reflow 2 times
 - 2. Initial value shall be after 24 h at room temperature.
- 4. Shift series resistance at after above tests should be less than \pm 15 % or less than \pm 5 k Ω In case Resistance to soldering heat, high temperature storage (\pm 125 °C \times 1 000 h) shift series resistance at after above tests should be less than \pm 20 % or \pm 10 k Ω

♦ Air- reflow

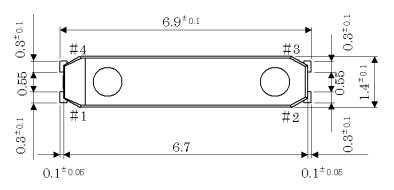
Pre heating temperature : Tp1 \sim Tp2 = + 170 $^{\circ}$ C Peak temperature must not exceed + 260 $^{\circ}$ C and the duration of over + 220 $^{\circ}$ C should be 35 s

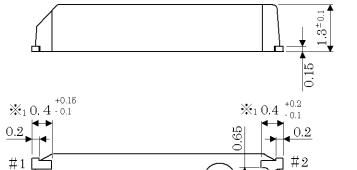
T (Temperature)



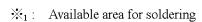
[5] Dimensions and Marking layout

1. Dimensions









#4

Metal may be exposed on the top or bottom of this product.This will not affect any quality, reliability or electrical spec.

0.25

2. Internal Connection



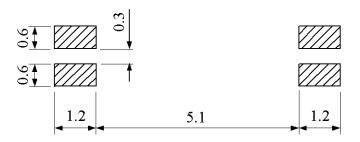
Terminal thickness	0.15 mm
Lead Frame	42Alloy
Terminal treatment	Pb Free Solder plate
	$15 \pm 10 \mu m$
Molding	Epoxy Compound
	(Halide free)
Compound color	Black

Do not connect # 2 and # 3 terminals to any external circuits (including GND).

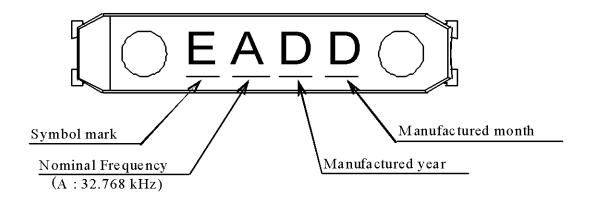
Туре	MC-146	Unit	1 = 1 mm
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3. Recommended soldering pattern

Unit : 1 = 1 mm



4. Marking layout



Symbol of Manufacturing year

Year digit	1	2	3	4	5	6	7	8	9	0
Marking	A	В	С	D	Е	F	G	Н	J	K

Year digit(1st) of the Production

Symbol of Manufacturing month

Month digit	1	2	3	4	5	6	7	8	9	10	11	12
Marking (Halide free)	A	В	С	D	Е	F	G	Н	J	K	L	М

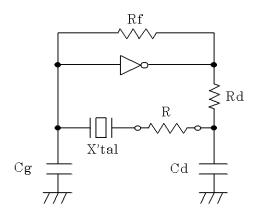
◆ The above marking layout shows only marking contents and their approximate position and it is not for font, size and exact position.

Type $MC-146$ Unit $1=1 \text{ mm}$

[6] Notes

- 1. Max two (2) times reflow is allowed. Once miss soldering is happened, hand work soldering by soldering iron is recommended. (+ $350 \,^{\circ}\text{C} \times \text{within 5 sec.}$)
- 2. Patterning should be followed by our recommended one.
- 3. Applying excessive excitation force to the crystal unit may cause deterioration damage.
- 4. Unless adequate negative resistance is allocated in the oscillation circuit, start up time of oscillation may be increased, or no oscillation may occur.

How to check the negative resistance.



- (1) Connect the resistance (R) to the circuit in series with the crystal unit.
- (2) Adjust R so that oscillation can start (or stop).
- (3) Measure R when oscillation just start (or stop) in above (2).
- (4) Get the negative resistance

$$-R = R + CI$$
 value.

(5) Recommended -R

$$|-R| > CI \times (5 \sim 10)$$

- 5. The shortest patterning line on board is recommendable. Too long line on board may cause of abnormal oscillation.
- 6. To avoid mull function, no pattern under or near the crystal is allowed. Solder paste should be more than $150 \mu m$ thickness.
- 7. This device must be stored at the normal temperature and humidity conditions before mounting on a board.
- 8. Too much exciting shock or vibration may cause deterioration on damage.
 Depending on the condition such as a shock in assembly machinery, the products may be damaged.
 Please check your condition in advance to maintain shock level to be smallest.
- 9. Depending on the conditions, ultrasonic cleaning may cause resonant damage of the internal crystal unit. Since we are unable to determine the conditions (type of cleaning unit, power, time, conditions inside the bath, etc.) to be used in your company, we cannot guarantee the safety of this unit when it is cleaned in an ultrasonic cleaner.
- 10. Ink marking may be damaged by some kind of solvent, please take precautions when choosing solvent by your selves.
- 11. Please refer to packing specification regarding how to storage the products in the pack.

TAPING SPECIFICATION

1. APPLICATION

This document is applicable to MC-146.

2. CONTENTS

Item No.	Item	Page
[1]	Taping specification	1 to 2
[2]	Shipping carton	3
[3]	Marking	
[4]	Quantity	4
[5]	Storage environment	
[6]	Handling	

[1] Taping specification

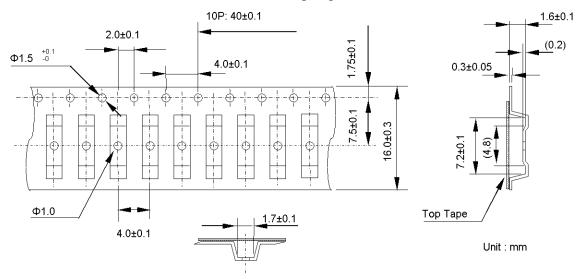
Subject to EIA-481 and IEC 60286

(1) Tape dimensions

TE1604L

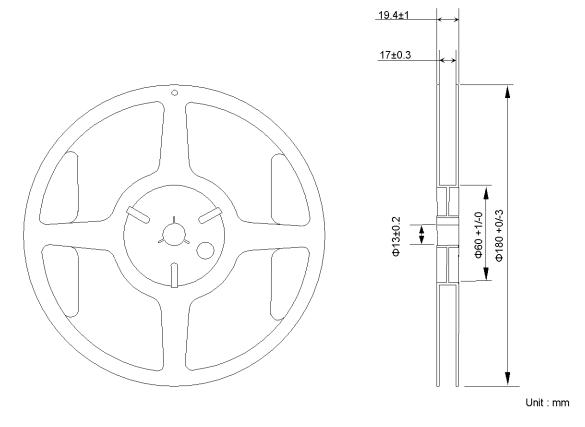
Material of the Carrier Tape: PS

Material of the Top Tape : PET+PE



(2) Reel dimensions

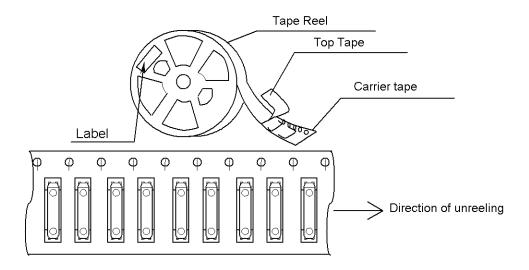
Material of the Reel : PS



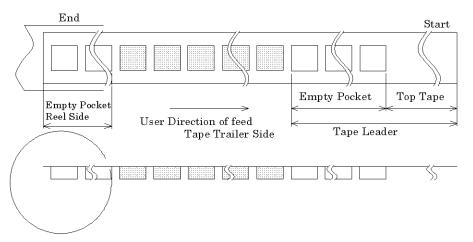
Form and Size of reel window shows are one of the example

(3) Packing

(a) Tape & Reel



(b) Start & End Point



It	Empty Space	
Tape Leader	Top Tape	Min. 1 000 mm
	Carrier Tape	Min. 160 mm
Tape Trailer	Top Tape	Min. 0 mm
	Carrier Tape	Min. 160 mm

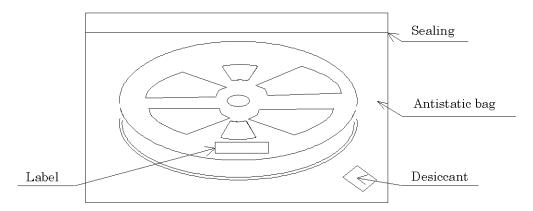
(4) Peel force of the cover tape

(a) angle : cover tape during peel off and the direction of unreeling shall be 165° to 180° .

(b) peel speed: 300 mm/min

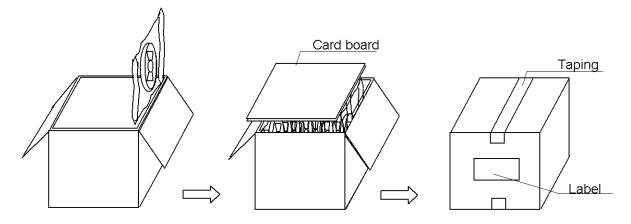
[2] Shipping Carton

a) Packing to antistatic bag



b) Packing to shipping carton

If there are room in the outer box, material is put in a shock absorbing together.



[3] Marking

- (1) Reel marking
 - Reel marking shall consist of:
 - 1) Parts name
 - 2) Quantity
 - 3) Manufacturing Date or symbol
 - 4) Manufacturer's Date or symbol
 - 5) Others (if necessary)
- (2) Shipping carton marking
 - Shipping carton marking shall consist of :
 - 1) Parts name
 - 2) Quantity

[4] Quantity

• 3 000 pcs./reel

[5] Storage environment

- (1) To storage the reel at +15 °C to +35 °C, 25 %RH to 85 %RH of Humidity.
- (2) To open the packing just before using.
- (3) Not to expose the sun.
- (4) Not to storage with some erosive chemicals.
- (5) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

[6] Handling

To handle with care to prevent the damage of tape, reel and products.

- PROCESS QUALITY CONTROL -

CODE: MC-146

Control No: M-9803-AGE-2 SURFACE MOUNTING TYPE CRYSTAL

MC - 146

MANUFACTURING PROCESS CHART		No	SECTION	SPECIFICATIONS	INSPECTION AND CONTROL ITEMS	INSPECTION METHOD	MEASURING INSTRUMENTS	DATA COLLECTION
CRYSTAL (SiO2 COATING)		1'	MALAYSIA PLANT	PURCHASING SPECIFICATION	APPEARANCE	SAMPLING	MICROSCOPE	IN-COMING INSPECTION
			(Sub-Contractor)					
FRAME Y		2	MALAYSIA PLANT	MANUFACTURING INSTRUCTION SHEET	APPEARANCE	SAMPLING	MICROSCOPE	PROCESS DATA SHEET
∇			(Sub-Contractor)	MANUFACTURING INSTRUCTION SHEET	DIMENSION	SAMPLING	T.M.S	PROCESS DATA SHEET
INCOMING		3	MALAYSIA PLANT	MANUFACTURING INSTRUCTION SHEET	APPEARANCE	SAMPLING	VISUAL INSPECTION	PROCESS DATA SHEET
INSPECTION			(Sub-Contractor)					POLICE STATE OF THE POST PROPERTY AND
		4	MALAYSIA PLANT	MANUFACTURING INSTRUCTION SHEET	APPEARANCE	SAMPLING	MICROSCOPE	PROCESS DATA SHEET
	•		(Sub-Contractor)		4 1			
2	CRYSTAL WELDING	5	MALAYSIA PLANT	SOLDER PLATING	S.P THICKNESS	SAMPLING	FLUOROSCOPY	PROCESS DATA SHEET
<u>T</u>			(Sub-Contractor)	SPECIFICATION SHEET	APPEARANCE	SAMPLING	VISUAL INSPECTION	PROCESS DATA SHEET
3	TRANSFER MOULDING	6	MALAYSIA PLANT	MANUFACTURING INSTRUCTION SHEET	APPEARANCE	SAMPLING	VISUAL INSPECTION	PROCESS DATA SHEET
J		ļ	(Sub-Contractor)	**************************************	**************************************		AAAMMAANAAAAAAAAAAAAAAAAAAAAAAAAAAAAAA	
4	1st PRESSING	7	MALAYSIA PLANT	MANUFACTURING INSTRUCTION	APPEARANCE	SAMPLING	MICROSCOPE	PROCESS DATA SHEET
1		ļ	(Sub-Contractor)		DIMENSION	SAMPLING	VERTICAL COMPARATOR	PROCESS DATA SHEET
(5)	SOLDER PLATING	8	MALAYSIA PLANT	MANUFACTURING INSTRUCTION SHEET	ELECTRICAL CHARACTERISTIC	100% INSPECTION	TO CHECKING By m/c	PROCESS DATA SHEET
人		1	(Sub-Contractor)	MANUFACTURING INSTRUCTION SHEET	TAPING STRENGTH	SAMPLING	PEEL BACK TESTER	PROCESS DATA SHEET
(6)	MARKING	THE REAL PROPERTY.		QUALITY STD.	ELECTRICAL CHARACTERISTIC	SAMPLING	TO&CI CHECKER	OGI INSP.SHEET
9	2nd PRESS	9	MALAYSIA PLANT	QUALITY STD.	APPEARANCE	SAMPLING	MICROSCOPE	OGI INSP.SHEET
人			(Sub-Contractor)	VARIATION AND AND AND AND AND AND AND AND AND AN	The state of the s	where Are Transport American	NAVALLIANTANIAN AND AND AND AND AND AND AND AND AND A	and the state of t
(2)	FINAL INSPECTION	10-1	MALAYSIA FLANT	MANUFACTURING INSTRUCTION SHEET	EXPORT CUSTOMER LIST		ALINE AND ASSESSED.	EXPORT DOCUMENTS
	AND TAPING		(Sub-Contractor)	DAILY SHIPPING LIST	FREQUENCY			
	OUTGOING INSPECTION				QUANTITY		And the same and t	
(10-1)	,	10-2	MALAYSIA PIANT	MANUFACTURING INSTRUCTION SHEET	EXPORT CUSTOMER LIST		*** **** ****	EXPORT DOCUMENTS
4	Pre-PACKING	Ì		DAILY SHIPPING LIST	FREQUENCY	artes are		
) PACKING			THE PROPERTY OF THE PROPERTY O	QUANTITY		And the first of t	

10-Sep-08

- PROCESS QUALITY CONTROL -

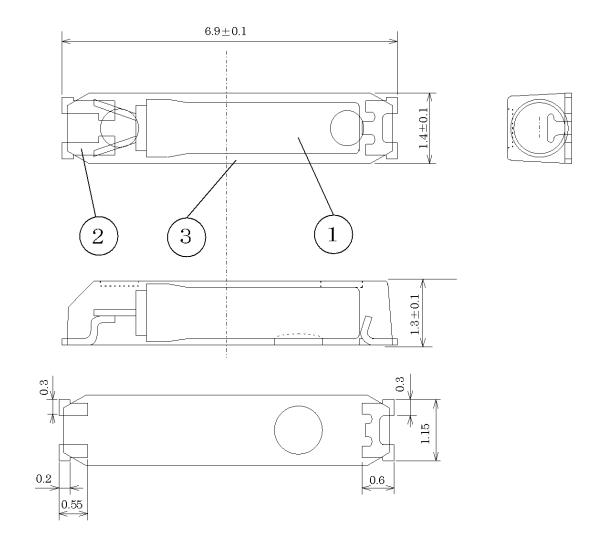
CODE: MC-146

Control No : M-9803-AKE-1

RESPONSIBLE STANDARD AND INSPECTION AND INSPECTION MEASURING DATA MANUFACTURING PROCESS CHART No SECTION SPECIFICATIONS CONTROLITEMS METHORD INSTRUMENTS COLLECTION 1' SUB-CONTRACTOR PURCHASING SPECIFICATION CRYSTAL APPEARANCE SAMPLING PIUG GAUGES IN-COMMING INSPECTION (SiO2 COATING) INCOMING INSPECTION STD. DIMENSION MICROSCOPE DATA SHEET LEAD FRAME 2 SUB-CONTRACTOR MANUFACTURING INSTRUCTION SHEET APPEARANCE 100% INSPECTION MICROSCOPE PROCESS DATA SHEET MANUFACTURING INSTRUCTION SHEET DIMENSION SAMPLING T.M.S. PROCESS DATA SHEET INCOMING MANUFACTURING INSTRUCTION SHEET STRENGTH SAMPLING PUSH&PULL GAUGE FROCESS DATA SHEET INSPECTION 3 ISUB-CONTRACTOR MANUFACTURING INSTRUCTION SHEET APPEARANCE 100% INSPECTION MICROSCOPE PROCESS DATA SHEET SAMPLING PROCESS DATA SHEET 4 SUB-CONTRACTOR MANUFACTURING INSTRUCTION SHEET APPEARANCE SAMPLING MICROSCOPE PROCESS DATA SHEET CRYSTAL WELDING 5 SUB-CONTRACTOR SOLDER PLATING S.P THICKNESS SAMPLING FLUOROSCOPY PROCESS DATA SHEET SUB-CONTRACTOR SPECIFICATION SHEET APPEARANCE SAMPLING VISUAL INSPECTION PROCESS DATA SHEET 5 SUB-CONTRACTOR MANUFACTURING INSTRUCTION SHEET | APPEARANCE TRANSFES MOULDING SAMPLING VISUAL INSPECTION PROCESS DATA SHEET 7 SUB-CONTRACTOR MANUFACTURING INSTRUCTION APPEARANCE SAMPLING MICROSCOPE PROCESS DATA SHEET 1st PRESSING DIMENSION SAMPLING INSPECTION JIG PROCESS DATA SHEET B SUB-CONTRACTOR MANUFACTURING INSTRUCTION SHEET ELECTRICAL CHARACTERISTIC 100% INSPECTION FOICHECKING By m/c PROCESS DATA SHEET SOLDER PLATING MANUFACTURING INSTRUCTION SHEET TAPING STRENGTH SAMPLING STRENGTH TESTER PROCESS DATA SHEET QUALITY STD. ELECTRICAL CHARACTERISTIC SAMPLING TO&CL CHECKER DGLINSP.SHEET 9 SUB-CONTRACTOR QUALITY STD. MARKING APPEARANCE SAMPLING MICROSCOPE OGLINSP, SHEET 10 SUB-CONTRACTOR MANUFACTURING INSTRUCTION SHEET EXPORT CUSTOMER LIST EXPORT DOCUMENTS 2nd PRESS DAILY SHIPPING LIST PREQUENCY QUANTITY FINAL INSPECTION AND TAPING OUTGOING INSPECTION (10) PACKING EXPORT

200.04.26

Unit:mm



3	Molding	Epoxy Compound (Halide free)	
2	Lead	4 2 Alloy	Solder Plating (Pb free)
1	Crystal C-5SH		
No.	Name of Part	Material	Remarks

RELIABILITY TEST DATA

Product Name: MC-146 (Halide free mold)

The Company evaluation condition

We evaluate environmental and mechanical characteristics by the following test condition . No. F-M-980301-05-001EH

			VALUE *1 *2		FAIL
No.	ITEM	TEST CONDITIONS	Δf/f	Qty	Qty
			$[1 \times 10^{-6}]$	[n]	[n]
		100 g dummy (ETC Standard)			
1	Shock	drop from 1 500 mm height on to the	*3 ± 5	22	0
		concrete 3 directions 10 times			
		10 Hz to 55 Hz amplitude 0.75 mm			
2	Vibration	55 Hz to 500 Hz acceleration 98 m/s ²	*3 ± 3	22	0
		$10 \text{ Hz} \rightarrow 500 \text{ Hz} \rightarrow 10 \text{ Hz}$ 15 min / cycle			
		6 h (2 h × 3 directions)			
	Resistance to	For convention reflow soldering furnace			
3	soldering heat	(2 times)	± 5	22	0
		The measurement is after 24 h			
4	High temperature	a) +125°C× 1 000 h	*3 a) ± 20	a) 22	a) 0
	storage	b) +85 °C× 1 000 h	*3 b) ± 10	b) 22	b) 0
5	Low temperature	-55 °C× 1 000 h	*3 ± 10	22	0
	storage				
6	Temperature	+85 °C× 85 %RH × 1 000 h	*3 ± 10	22	0
	humidity storage				
7	Temperature cycle	-55 °C ⇔ +125 °C	*3 ± 10	22	0
		30 min at each temp. 100 cycles			
8	Shear	10 N press for 10 s ± 1 s	No peeling - off at a	22	0
		Ref. IEC 60068-2-21	solder part		
9 Pull - off		10 N press for 10 s ± 1 s	No peeling - off at a	22	0
	157-117	Ref. IEC 60068-2-21	solder part		
		Bend width reaches 3 mm and hold for	No peeling - off at a		
10	Substrate bending	$5 \text{ s} \pm 1 \text{ s} \times 1 \text{ time}$	solder part	22	0
		Ref. IEC 60068-2-21			
		Dip termination into solder bath at	Termination must be		
11	Solderability	+235 °C ± 10 °C for 3 s	95 % covered	11	0
		(Using Rosin Flux)	with fresh solder		
12	Solvent resistance	Ref. JIS C 0052 or IEC 60068-2-45	The marking shall be legible	11	0

Notes

- 1. *1 Each test done independently.
- 2. *2 Measuring 1 h to 24 h later leaving in room temperature after each test.
- 3. *3 Pre conditionings Initial value shall be after 24 h at room temperature.
- 4. Shift series resistance at after above tests should be less than ± 15 % or less than ± 5 k Ω . In case Resistance to soldering heat, high temperature storage (± 125 °C × 1 000 h) shift series resistance at after above tests should be less than ± 20 % or less than ± 10 k Ω .

